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Tailoring the Switching Efficiency of Magnetic Tunnel Junctions by the Fieldlike Spin-Orbit Torque

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Current-induced spin-orbit torques provide a versatile tool for switching magnetic devices. In perpendicular magnets, the dampinglike component of the torque is the main driver of magnetization reversal. The degree to which the fieldlike torque assists the switching is a matter of debate. Here we study the switching of magnetic tunnel junctions with a Co-Fe-B free layer and either W or Ta underlayers, which have a ratio of fieldlike to dampinglike torque of 0.3 and 1, respectively. We show that the fieldlike torque can either assist or hinder the switching of Co-Fe-B when the static in-plane magnetic field required to define the polarity of spin-orbit torque switching has a component transverse to the current. In particular, the noncollinear alignment of the field and current can be exploited to increase the switching efficiency and reliability compared with the standard collinear alignment. By probing individual switching events in real time, we also show that the combination of transverse magnetic field and fieldlike torque can accelerate or decelerate the reversal onset. We validate our observations using micromagnetic simulations and extrapolate the results to materials with different torque ratios. Finally, we propose device geometries that leverage the fieldlike torque for density increase in memory applications and synaptic weight generation.

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I. INTRODUCTION

Current-induced spin-orbit torques (SOT) [1] offer an efficient and scalable way to control the magnetization of spintronic devices [2], including magnetic tunnel junctions (MTJs) [3–7], domain-wall racetracks [8–11], and logic gates [12–15]. For its relevance in memory and computing applications, SOT switching has undergone much progress in terms of reliability, operation speed, energy efficiency, as well as realizing zero-external-field switching in systems with perpendicular magnetization [16]. In these systems, which offer the best scaling prospects in terms of device integration, a static magnetic field along the current direction is required to break the SOT symmetry and determine the switching polarity [2]. The SOT can be decomposed into two orthogonal components, the longitudinal dampinglike torque (DLT) and the transverse fieldlike torque (FLT) [1,17–19]. Most work on switching, however, concentrates on the DLT, for it is known to drive the magnetization reversal when assisted by the longitudinal field [1–3,20,21], whereas the FLT is often disregarded.

Similarly to a magnetic field of fixed orientation, however, the FLT has different effects on the reversal dynamics. In the macrospin picture, it promotes the precession of the magnetization about the direction perpendicular to the current flow [22], whereas, in the case of incoherent magnetization reversal, it lowers the energy barrier for domain nucleation [23] and can favor the propagation of domain walls [24]. The FLT can therefore be probed by studying the switching in different current-field configurations.

An in-plane magnetic field applied perpendicular to the current is found to promote (hinder) the nucleation of magnetic domains [23] and to reduce (increase) the switching threshold when applied along (against) the effective field of the FLT [24]. In samples with strong FLT, varying the direction of the assisting magnetic field in the plane is found to change the threshold current for SOT switching [25] and the onset of the backward switching [26], which could be exploited to realize unipolar switching. These results show that the FLT acts as an internal effective field that superposes to the external one. Simulations also suggest that the FLT can enable field-free switching, supposing materials with a specific FLT-to-DLT ratio (β) are employed [22,27,28]. On the other hand, the FLT can increase the switching threshold by tilting the magnetization into the plane and induce precessional dynamics,

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which impairs the switching reliability [29]. The increased susceptibility to switching errors, observed in strong-FLT samples, has been attributed to the domain-wall reflection from the edges of the magnetic structure [26,30]. Thus, whereas magnetization reversal is relatively well understood in SOT materials in which the DLT dominates over the FLT, such as Pt [9,17,31] and W [32–34], strong-FLT materials, such as Ta [17–19,35], Hf [32,35–37], and topological insulators [38–40], offer additional opportunities to tune the switching efficiency. Experimental work addressing the FLT, however, has only focused on the switching of relatively large (micrometer-scale) structures, and used either Pt [23,24] or Ta [25,26,30] as the SOT source. The role of the FLT in the reversal dynamics and its effect on the threshold current of nanoscale devices such as MTJs are not known.

In this paper we investigate the influence of the FLT and in-plane external field on the switching of nanoscale MTJ devices based on W/Co-Fe-B and Ta/Co-Fe-B heavy metal/ferromagnetic layers. Our results elucidate the impact of the FLT on the switching dynamics, reliability, and threshold conditions for both low- and strong-FLT systems, showing that it can have advantages for practical applications. By measuring individual switching events in the time domain, we find that the FLT directly affects the energy barrier for reversal and accelerates or decelerates the switching onset. We also show that β can be estimated at device level from the switching measurements in the presence of a transverse field. Using micromagnetic simulations, we further elucidate the effects of the FLT and in-plane external field and extrapolate the results to materials with different FLT strengths. Finally, we propose device geometries that can leverage the interplay of the external field and FLT for either high-density memory applications or the generation of synaptic weights.

II. EXPERIMENT

We use MTJ devices patterned into circular pillars with the diameter of 80 nm [Fig. 1(a)] and grown on top of a heavy metal (HM) current injection track. The device structure is HM/Co-Fe-B/MgO/Co-Fe-B(1.1)/SAF(10.5), where the numbers in parentheses indicate the thickness in nanometers and SAF denotes synthetic antiferromagnet. The SAF is used to pin the upper Co-Fe-B layer upward. In the study, we compare MTJs comprising β -W(3.5)/Co-Fe-B(0.9) and Ta(5)/Co-Fe-B(1). The resistivity of the W, Ta, and Co-Fe-B layers is estimated to be 160, 210, and 120 $\mu\Omega$ cm, respectively. The efficiency of the DLT (FLT) obtained from harmonic Hall measurements [17] are $\xi_{DL(FL)} = -0.33 \pm 0.03 (-0.10 \pm 0.02)$ for the W-based samples [34] and $\xi_{DL(FL)} = -0.11 \pm 0.01 (-0.11 \pm 0.03)$ for the Ta-based samples. In both types of samples, the free layer has an easy axis along z and its magnetization can be reversed between up and down states without any

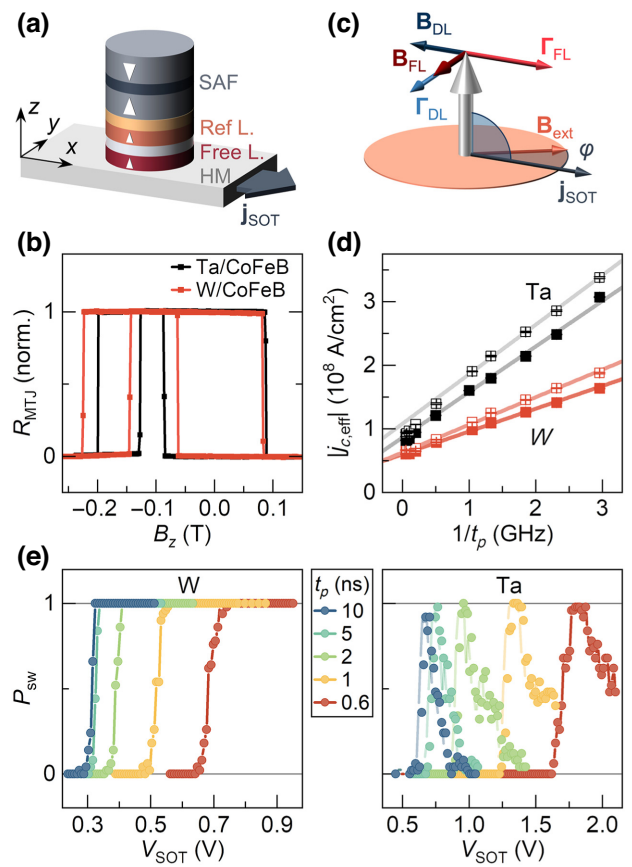


FIG. 1. (a) Schematics of the sample geometry. (b) Comparison of the normalized hysteresis loops of MTJ with W and Ta underlayers. (c) Schematics of the dampinglike and fieldlike SOT $\Gamma_{DL,FL}$ and the corresponding effective fields $B_{DL,FL}$ induced by j_{SOT} . (d) Comparison of the effective critical switching currents $j_{c,eff}$ for different pulse widths obtained for an applied in-plane field $B_x = 32$ mT. Open (full) symbols indicate switching to the up (down) state. Lines are linear fits to the data in the intrinsic regime ($1/t_p \geq 1$ GHz). (e) Probability of switching to the up state as a function of the SOT bias out of 50 trials.

stable intermediate levels [Fig. 1(b)]. Moreover, the SAF structure creates a dipolar field $|B_{SAF}| \leq 10$ mT along $-z$ that favors the up-to-down reversal of the free layer in all samples.

In the experiment, a positive V_{SOT} applied across the SOT track induces a current j_{SOT} along the x direction. This current generates dampinglike and fieldlike SOT on the bottom Co-Fe-B (free layer) magnetization, as shown in Fig. 1(c). The magnetic field B_{ext} is applied in the xy plane along the direction given by the angle φ with respect to x . The final state after the SOT pulse injection is read by applying a small oscillating voltage (10 mV) on the MTJ. Additionally, the free layer magnetization can be probed during the SOT pulse, in order to perform the time-resolved measurements discussed in Sec. V. To do that, a small current shunt across the pillar (< 1.3 MA/cm²) is

used to read the real-time resistance change of the junction on an oscilloscope [5]. This resistive change corresponds to the change of the magnetization direction.

III. SOT SWITCHING FOR COLLINEAR ALIGNMENT OF CURRENT AND FIELD

First, we compare the SOT switching in both types of MTJ for collinear alignment of the current and in-plane magnetic field ($\varphi = 0^\circ$). We apply a 32 mT field along x and measure the probability of switching P_{sw} of the free layer upon repeated pulsing with different amplitudes V_{SOT} . After each pulse, we read the MTJ state and reset it to the initial state afterwards. We repeat this procedure for different pulse widths t_p . Figure 1(d) shows the effective critical current $j_{c,eff}$, defined as the current density in and below the free layer for which $P_{sw} = 0.5$ [41]. In the short-pulse limit, the critical current scales as $j_{c,eff} = j_{c0} + q/t_p$, where j_{c0} is the intrinsic critical current and q is the effective charge parameter that determines the rate at which angular momentum is transferred to the free layer [42–45]. From the linear fit to the data, we obtain $j_{c0} = 62 \pm 2$ MA/cm² and $q = 396 \pm 38$ C/m² for W, and $j_{c0} = 97 \pm 15$ MA/cm² and $q = 748 \pm 44$ C/m² for Ta. The small difference in j_{c0} can be attributed to the difference in the thermal stability and heat dissipation in the system, whereas the factor approximately equal to 2 between the q in W and Ta reflects mainly the relative difference between the DLT efficiencies of these metals [1,46].

Figure 1(e) shows P_{sw} for down-to-up switching, which is significantly different for W and Ta. In the case of W, the switching to the opposite state remains reliable after reaching $P_{sw} = 1$. In the case of Ta, however, the increase of P_{sw} with V_{SOT} toward 1 is followed by a gradual increase of error rate, leaving only a very limited interval of voltages suitable for reliable operation. This behavior is not unexpected in Ta/Co-Fe-B, as similar observation have been reported earlier [26,30] and attributed to the FLT. However, contrary to Ref. [26], in which Hall cross samples with a single magnetic layer were used, in the MTJ devices we only observe the onset of large switching errors for one of the two switching directions that is opposed by B_{SAF} .

IV. SOT SWITCHING FOR NONCOLLINEAR ALIGNMENT OF CURRENT AND FIELD

Figure 2 summarizes the result of switching by 10-ns-long pulses in a field $B_{ext} = 40$ mT applied at different angles φ relative to the current. In both samples, the magnitude of the switching voltage decreases (increases) monotonously with increasing φ for negative (positive) SOT pulses, which—as we discuss further on—is a manifestation of the superposition of the y component of B_{ext} with the effective field of the FLT (B_{FL}). Figures 2(a) and 2(b) show P_{sw} of the up-to-down switching for different

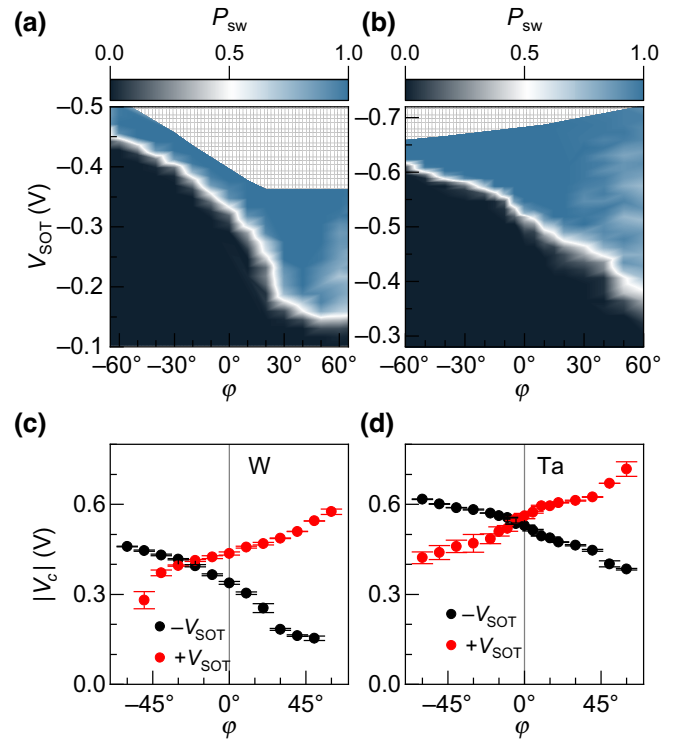


FIG. 2. Switching probability and critical voltage V_c as a function of the angle between j_{SOT} and B_{ext} . The two-dimensional (2D) diagrams in (a,b) show the under-critical (black) and over-critical (blue) conditions for switching to the up state induced by $t_p = 10$ -ns-long current pulses for different orientations of $B_{ext} = 40$ mT. The hashed areas indicate the range of parameters that were not investigated in the study. Plots (c),(d) show the corresponding V_c for both pulse polarities. The results for the W and Ta samples are shown in (a),(c) and (b),(d), respectively.

SOT pulse and field configurations. As the critical voltage $V_c = V_{SOT}(P_{sw} = 0.5)$ decreases in absolute value for $\varphi > 0$, we observe a broadening of the transition from a below- to over-critical voltage, as well as an increased occurrence of switching errors, which becomes significant above $\varphi \approx 30^\circ$. This reduced reliability is a result of the decrease of the longitudinal B_x component required to break the symmetry of the DLT and, possibly, of the FLT-induced precessional dynamics supported by increasing B_y . On the other hand, for $\varphi < 0$, the increase of $|V_c|$ is not related to deterioration of the switching reliability for the over-critical V_{SOT} . This indicates that the y component of B_{ext} can suppress the effect of the FLT even when V_{SOT} is large. Moreover, the increase of $|V_c|$ is accompanied by the narrowing of the transition region (toward negative φ). This is in line with the increase of the switching barrier height, which results in a sharper transition for thermally-activated switching [47].

Figures 2(c) and 2(d) compare the absolute values of the critical voltages extracted from the diagrams (black) to those corresponding to the other switching direction (red).

Except for small variations, the overall trend of V_c with φ is similar in both samples. Notably, the trends for the two pulse polarities have opposite slope; the shift of the apparent crossing point to the left of $\varphi = 0^\circ$, which can be seen in both panels, is attributed to small differences in the energy landscape of the two reversal directions. These can arise due to structural nonuniformity in the free layer or, more likely, to B_{SAF} , which makes the switching to the down state (by negative V_{SOT}) generally more efficient. The presence of the less reliable switching regions (associated with low $|V_c|$) defines a finite angular section of φ close to 0° that can be exploited for tuning the conditions for deterministic bipolar switching (see Sec. VII). The results of switching by 10 and 1-ns-long pulses are compared in the Supplemental Material [48]. We observe a similar angular dependence of V_c for long and short pulses, even though switching by short pulses requires a larger voltage, as expected. The conclusions of the above paragraph are thus independent of the pulse width at least down to 1-ns-long pulses.

To understand the similarity between the W and Ta samples, we note that both are negative spin Hall angle materials and have SOT of equal sign. A positive SOT pulse induces B_{FL} pointing along $-y$, as schematized in Fig. 1(c), and the Oersted field B_{Oe} pointing also along $-y$. From symmetry considerations, the y component of the external field subtracts from (adds up to) B_{FL} induced by positive (negative) V_{SOT} when $\varphi > 0$; the opposite occurs when $\varphi < 0$. When the two fields add together, the switching is favored, in agreement with previous results obtained in Ta-based samples [25,26]. Ta is known to induce strong FLT, with β ranging from 0.7 to over 4 [17–19,26,35,37,49], whereas β is typically less than 0.4 in the case of W [33,34]. Thus, it may seem surprising that V_c changes by a similar amount with φ in Figs. 2(c) and 2(d). However, the Ta samples used in this study provide only moderate FLT with $\beta = 1.05 \pm 0.08$, and the W samples $\beta = 0.3 \pm 0.07$. Moreover, changing φ does not affect only B_{FL} , but also B_{DL} that is three times weaker in Ta than in W, which partially compensates for the larger β in Ta.

To exclude the effect of an insufficient amount of symmetry-breaking field B_x , we also study the switching when only the transverse component of the external field B_y is varied and $|B_x|$ is fixed. For each B_y , we send a train of 1-ms pulses of increasing amplitude and determine the switching threshold. Figure 3(a) compares the switching loops for W and Ta samples measured in $B_x = 40$ mT. The extracted thresholds are plotted in Fig. 3(b). In both cases, we observe that V_c changes the most when B_y is close to zero, and then saturates in either field direction. This variation can be understood as the effect of the effective transverse field $B_y + B_{\text{FL}} + B_{\text{Oe}}$ on the switching and confirms that in both systems, B_{FL} points along $-y$ when V_{SOT} is positive (same sign as in Fig. 2). This trend is opposite to the one observed in Co/Pt/AlO_x dots, as expected because

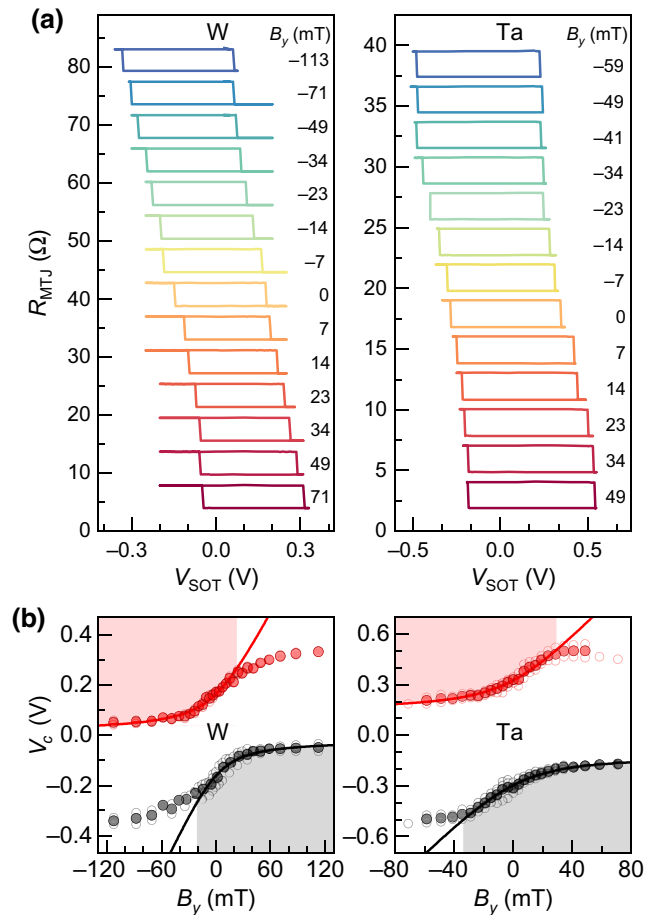


FIG. 3. (a) Switching loops of W- and Ta-based MTJ for different B_y at constant $|B_x| = 40$ mT. The MTJ resistance is measured as a function of V_{SOT} after applying a current pulse with $t_p = 1$ ms. The measurements are offset along the y axis for clarity. (b) Critical switching voltage as a function of B_y . The full symbols show the average of the individual V_c (open symbols) measured at positive and negative B_x . The lines are fits to the data (see text) in the range marked by the shaded areas.

of the opposite sign of the SOT in Pt with respect to W and Ta [24].

Measuring V_c as a function of B_y further allows for estimating B_{FL} at the device level. We start from the analytical formula for the switching threshold j_c^\perp in a transverse field obtained from the Landau-Lifshitz-Gilbert (LLG) equation [50], which, for $\beta \neq 0$, gives

$$j_c^\perp = \frac{2eM_s t}{\hbar \xi_{\text{DL}} \beta (2 + \alpha \beta)} \times \left[(1 + \alpha \beta) B_y \pm \sqrt{2\alpha \beta (2 + \alpha \beta) B_k^2 + B_y^2} \right]. \quad (1)$$

Here $M_s t$ is the unit surface magnetization of the free layer, α is the damping constant, and B_k is the effective anisotropy field. Theoretically, Eq. (1) is valid for $|B_y|$ up to B_k . In the experiment, however, B_x alone can promote

the switching, even in the absence of B_y . Therefore, the experimental V_c deviates from the model for $|B_y| \gtrsim |B_x|$ when the sign of B_y is such that it hinders switching. The range of validity of the model is thus reduced to $B_y \leq B_x$ ($B_y \geq -B_x$) for a positive (negative) SOT current, corresponding to the red (gray) shaded areas in Fig. 3(b).

We fit the data in the shaded regions of Fig. 3(b) by taking $V_c = RA_{\text{HM}}j_c^\perp + V_{c0}$, where A_{HM} is the cross section of the HM layer and V_{c0} is an offset that takes into account the effect of the constant B_x , which is not included in Eq. (1). We take $M_s = 1.05$ MA/m, $B_k = 0.2$ T (0.27 T), and $\xi_{\text{DL}} = -0.325(-0.108)$ for W (Ta), as measured in full and simplified MTJ stacks and at the device level [16,34], and let α , β , and V_{c0} vary as fit parameters. For simplicity, we neglect the Oersted field ($B_{\text{Oe}} \approx \mu_0 j_{\text{SOT}} t_{\text{HM}}/2$), which is more than 1 order of magnitude smaller than the SOT effective fields ($B_{\text{DL,FL}} = \xi_{\text{DL,FL}} \hbar j_{\text{SOT}} / (2eM_s t)$) in both samples. The fits [solid lines in Fig. 3(b)] give $\alpha = 0.029 \pm 0.005$ for W and 0.007 ± 0.001 for Ta, and $\beta = 0.30 \pm 0.03$ for W and 1.06 ± 0.03 for Ta. Despite the simplifications made, the values of β are in close agreement with those obtained from the harmonic Hall measurements (see Sec. II), namely 0.30 ± 0.07 for W and 1.05 ± 0.08 for Ta.

This result implies that a rather simple model based on the macrospin approximation of the LLG equation can be used to estimate β , even though the magnetization reversal is incoherent and proceeds via a more complex dynamics [5,24]. Moreover, this type of measurement can supplement the hysteresis loop-shift method in finite B_x [51] that is commonly used to evaluate B_{DL} at the device level, to estimate B_{FL} without the need to perform harmonic Hall measurements.

V. TIME-RESOLVED SWITCHING

We next investigate the impact of the FLT and B_y on the switching timescales. Because of the similarity of both types of samples, we only discuss the results for the W-based MTJ and present the results for Ta in the Supplemental Material [48]. We use a constant V_{SOT} that ensures reliable switching when 20-ns-long pulses are applied, and probe the magnetization in real time (see Sec. II and Ref. [5]). A voltage time trace acquired during each pulse, normalized to the difference between the up and down states [Fig. 4(a)] represents the perpendicular component of the magnetization of the free layer. In agreement with previous studies [5,6,45], each switching event comprises a single transition phase preceded and followed by a quiescent state. By fitting the data to a sigmoid function, we can quantify the activation delay (t_0) and the transition time (Δt) in every measurement. Repeating the acquisition many times in the same conditions provides information about the statistical distribution of the switching times. These characteristic timescales are not accessible when the

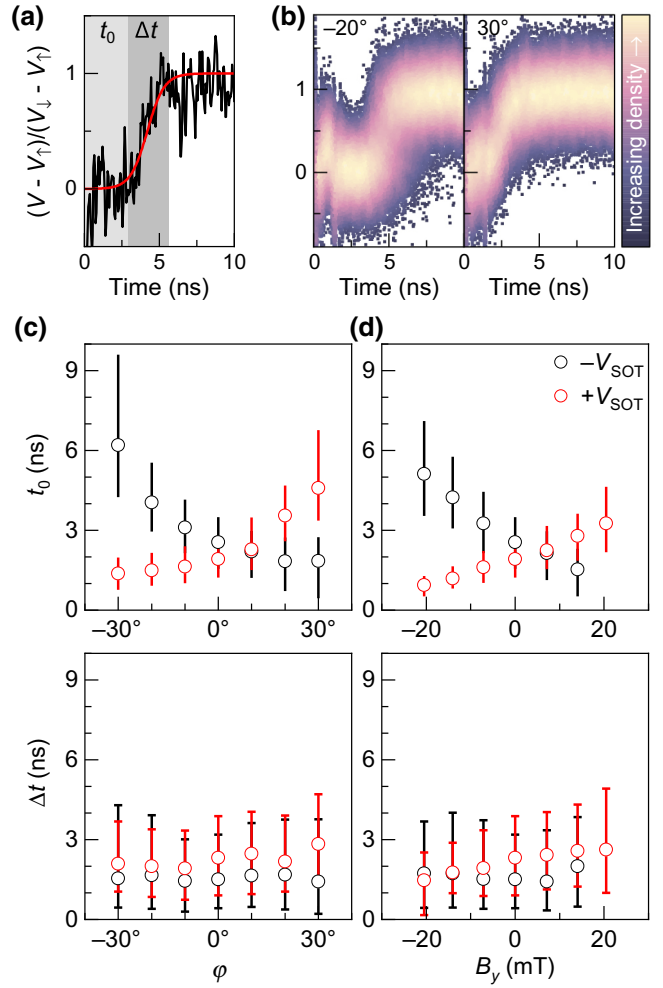


FIG. 4. (a) Representative single-shot switching time trace in a W-based MTJ induced by $V_{\text{SOT}} = -478$ mV. An in-plane field $B_{\text{ext}} = 40$ mT is applied along $\varphi = -30^\circ$. The delay t_0 and duration Δt of the reversal (gray shaded areas) are found by fitting the data to a sigmoid function (red line). (b) Overlay of 500 time traces acquired at $\varphi = -20^\circ$ (left) and $\varphi = 30^\circ$ (right). (c),(d) The activation delay t_0 and the transition time Δt obtained from fitting the switching traces (c) for different φ when $|B_{\text{ext}}| = 40$ mT and (d) for different B_y when $B_x = 40$ mT. The symbols give the median value, the vertical bars give the range of 10%–90% of the events.

magnetization state is detected postpulse, and should not be interchanged with the critical times obtained from the postpulse switching statistics.

Figure 4(b) shows an overlay of successful switching events measured in two different current-field configurations, $\varphi = -20^\circ$ (left) and 30° (right). For both angles, the traces overlap with a similar dispersion. However, whereas at -20° , no reversal starts earlier than 3 ns after the pulse onset, most reversals at 30° are already completed by that time. For any φ , we do not observe any pauses or intermediate levels in the reversals.

The statistical results for both switching directions as a function of the field orientation (constant $|B_{\text{ext}}|$) and of the transverse field (constant B_x) are summarized in Figs. 4(c) and 4(d), respectively. The plots of t_0 display a strong resemblance to the V_c dependence in Fig. 2, which corroborates the relation between both quantities [44,47]. Accordingly, t_0 increases when the transverse field components oppose one another. This shows that B_y (hence, also B_{FL}) directly affects the reversal onset, which is a manifestation of the energy barrier for nucleation of the reversed domain [5,6,23]. Because of nonlinear scaling of the attempt time with the height of the barrier, the change of t_0 is more significant than the change of critical voltage (compare Figs. 2 and 4) in the same range of B_y . On the contrary, the median of Δt varies little over the studied range, with only a weak increase with B_y for positive pulses. This result is consistent with the theory prediction that (i) the SOT-driven domain-wall velocity scales with B_y , such that Δt decreases when B_{FL} and B_y are parallel; and (ii) the amount of variation increases with the SOT efficiency, current, and Dzyaloshinskii-Moriya interaction (DMI) [24,52], although the dependence is rather weak unless a strong DMI is involved [52]. An increase of the domain-wall velocity by 25% upon changing B_y between ± 20 mT is demonstrated using samples based on Pt, which provides strong DMI [9]. However, a small to negligible effect is expected in materials with small DMI, such as Ta or W. In our W samples, the DLT efficiency is about three times higher and the DMI is more than 10 times weaker than in Pt. Therefore, we expect the variation of Δt to be less than 10% in the studied range of B_y , consistent with the data in Fig. 4. Similarly, we observe a minor variation of Δt in the Ta samples (Supplemental Material [48]).

VI. MICROMAGNETIC SIMULATIONS

In the following we discuss the effect of FLT and a transverse in-plane field in materials with different β . To explore SOT switching in a broad range of β , we perform micromagnetic simulations using MUMAX3 [53]. We simulate the dynamics of a single-layer nanomagnet with 80 nm in diameter discretized into a $(1.5 \times 1.5 \times 0.9)$ nm³ mesh. We model the free layer using the material parameters of the W/Co-Fe-B system: $M_s = 1$ MA/m, $A_{\text{ex}} = 15$ pJ/m, $B_k = 0.25$ T, $D = 0.2$ mJ/m², $\xi_{\text{DL}} = -0.3$, and $\alpha = 0.1$, and initialize its magnetization along z . As in the experiment, we apply a homogeneous magnetic field with different strength and orientation in the plane, and simulate the magnetization reversal induced by spin current to the nanomagnet. The current is supplied by rectangular pulses along x with a 0.1 ns rising and falling edge. We only discuss here the up-to-down reversal, noting that the simulations are fully deterministic owing to the absence of defects, thermal fluctuations, and SAF field, and, thus, the down-to-up reversal is the exact opposite of the former.

We simulate the switching time traces for different transverse fields (given by φ or B_y) and β , and observe that the timing of the reversal, as well as the switching outcome, depend on both the parameters (Supplemental Material [48]). Because not all simulations end in successful reversal, we define t_c as the time at which the average magnetization of the nanomagnet has undergone the first half of the reversal, i.e., $m_z = 0$. Figures 5(a) and 5(b) show t_c for different $|\beta| \leq 1.2$. At each field, we observe that t_c decreases with $\beta > 0$, because B_{FL} in this case supports the tilt of the magnetization induced by B_{DL} [24,30,50]. On the contrary, B_{FL} and B_{DL} compete when $\beta < 0$, and thus, t_c first increases with $\beta < 0$ until the effect of B_{FL} becomes dominant. Then also the trend of t_c with transverse field reverses, as visible in Fig. 5(b). Notably, the simulated datasets obtained for $\beta = 0.3$ reproduce the experimental trends, corresponding to $-V_{\text{SOT}}$ in Figs. 4(c) and 4(d). Moreover, one can notice in Fig. 5(a) that t_c increases for large $|\varphi|$, regardless of its sign. This effect is a consequence of the reduced B_x and is related to the increase of writing errors observed experimentally in Fig. 2. If B_x is kept constant, on the other hand, t_c roughly follows an exponential dependence on B_y , as shown in Fig. 5(b).

Combining the datasets for different β produces 2D diagrams of t_c as a function of β and φ or B_y , as shown in Figs. 5(c) and 5(d), respectively. Similarly, we can construct the diagrams for the switching threshold j_c , i.e., the lowest current resulting in the reversal of the magnetization, which is proportional to the variation of the switching energy barrier for different combinations of FLT and external field. Both types of diagrams closely resemble each other, which confirms the relation between t_c and j_c [11,43,44,47]. Figure 5(e) shows that j_c depends nonlinearly on φ and β with a saddle point at $\varphi = 0^\circ$ and $\beta = -0.8$ obtained for the given simulation conditions. This point marks the conditions, for which the net effect of B_{FL} and B_{ext} on the magnetization is the smallest. Note that, for β close to the saddle point, j_c further rises with $-\cos(\varphi)$, as B_x reduces. In contrast, Fig. 5(f) confirms the equivalence of B_{FL} and B_y with respect to their impact on j_c . This is visualized by the curves of constant current (white dashed lines), which follow straight lines. Importantly, this further validates the assumptions we made when estimating β using Eq. (1).

VII. DEVICE DESIGNS THAT EXPLOIT THE FLT

Two important challenges in the large-scale adoption of SOT switching for embedded memory applications are the comparatively higher critical current and device footprint compared with spin-transfer torque. A useful approach that can tackle both challenges together involves using a common SOT injection path for several MTJ devices and selecting the one to switch by the application of a voltage gate across the MTJ simultaneously with the SOT

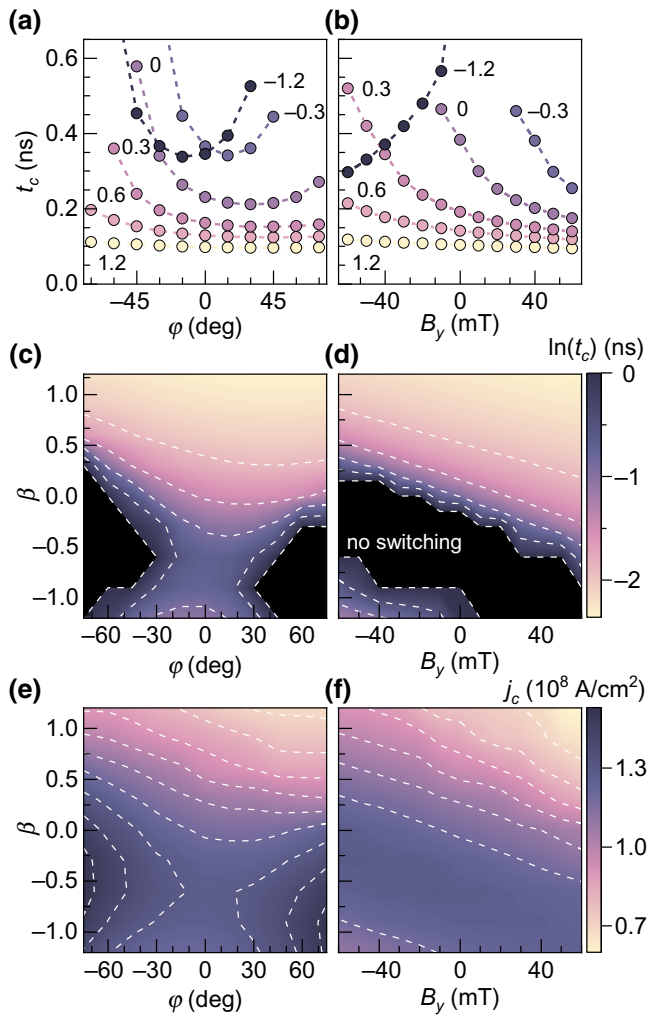


FIG. 5. Results of the zero-temperature micromagnetic simulations. The critical switching time t_c for different β when (a) $|B_{\text{ext}}| = 40$ mT and $j_{\text{SOT}} = -130$ MA/cm² and (b) $B_x = 40$ mT and $j_{\text{SOT}} = -120$ MA/cm². (c),(d) 2D diagrams of $\ln(t_c)$ for the parameters used in (a),(b). (e),(f) 2D diagrams of the critical current j_c as a function of (e) β and φ ($|B_{\text{ext}}| = 40$ mT) and (f) β and B_y ($B_x = 40$ mT). The diagrams comprise 13×9 and 11×7 data points, respectively. White dashed lines are isocurves to $\ln(t_c)$ and j_c .

pulse [41,54]. This scheme, however, requires applying two pulses for writing each bit. Here, we propose a device design in which the selectivity is intrinsic. This is possible by exploiting the FLT for the MTJ selection (Fig. 6). Moreover, the proposed geometry allows for reducing the writing energy at the same time. The schematics in Fig. 6(a) illustrates this concept on two MTJs placed on a common SOT track and initialized in the down state in the presence of a static magnetic field along $-x$ (provided externally or intrinsic [55]). The application of a positive “set” pulse on electrode IN_1 will induce j_{SOT} underneath both MTJs. Because of the geometry of the track, $\varphi < 0^\circ$ for MTJ_1 , whereas $\varphi > 0^\circ$ for MTJ_2 . Thus, in line with Figs. 2 and 4,

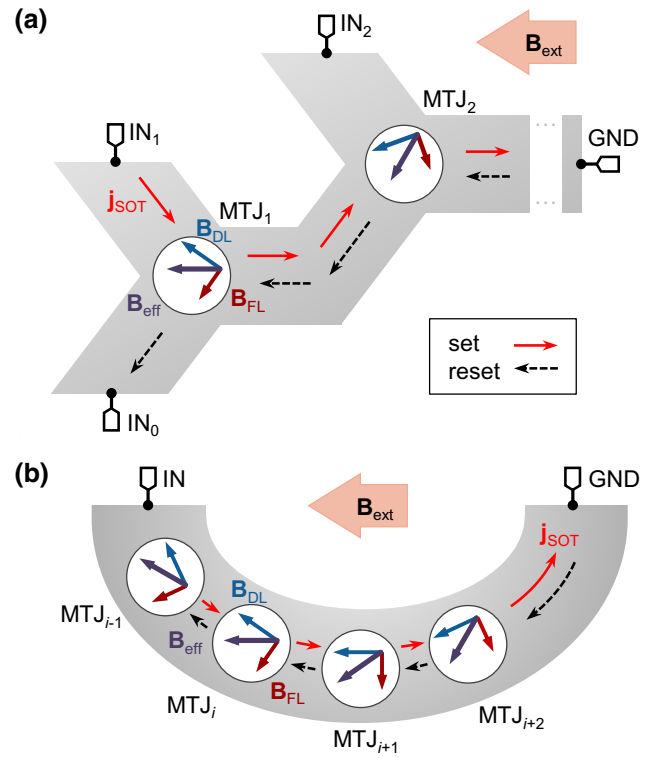


FIG. 6. Schematics of device concepts that take advantage of the FLT. (a) MTJ array sharing a common SOT track for high-density memory applications. The state of each MTJ can be “set” individually by applying a positive pulse to the respective input electrode, whereas all bits can be “reset” simultaneously by applying a negative pulse to the IN_0 electrode. (b) A synaptic weight generator consisting of a series of MTJs sharing a curved SOT track, such that $j_c(\text{MTJ}_i) < j_c(\text{MTJ}_{i+1})$.

the MTJ_1 can reverse to the up state at lower bias than the MTJ_2 . This allows us to “set” the MTJ_1 without affecting the MTJ_2 or any other device on the track. On the contrary, applying a negative pulse to electrode IN_0 results in $\varphi > 0^\circ$ underneath all MTJs, which will “reset” all at once to the down state. From Fig. 2, we can assume reliable switching up to $|\varphi| = 30^\circ$ (15°) using a W (Ta) under layer and an average difference of 100 mV between the FLT-assisted and hindered thresholds. On top of that, the average writing voltage reduces by 10%–20% compared with $\varphi = 0^\circ$.

Note that another challenge for the SOT switching of perpendicular magnets is the integration of a magnetic field source. In the proposed geometry, we assume a constant B_{ext} that can be integrated in devices by a built-in hard mask [55], exchange bias [56], or replaced by other symmetry-breaking mechanisms proposed in the literature [16].

A prospective application of MTJs, beyond their use as binary memories, is in computing, as a hardware realization of artificial synapses [57,58]. The efficient storing of synaptic weights requires memories with multilevel

(preferably analogue) conductance values. A series of MTJs connecting a top and a bottom electrode can serve this purpose [59]. It is however crucial that the MTJs can be switched selectively. Figure 6(b) shows a device that exploits the FLT and the MTJ position on a U-shaped SOT track to enable selective level programming. As φ gradually varies between the pillars along the track, each MTJ will switch at a well defined but different current, since $j_c(\text{MTJ}_i) < j_c(\text{MTJ}_{i+1})$. To increase the number of weight levels, more pillars can be accommodated on the SOT track. This could be simplified by patterning the track into a “wavy line”. Moreover, the scheme offers potential for very high selectivity, thanks to the possibility to separately optimize the MTJ size and position, the track bending radius, and the FLT strength.

VIII. CONCLUSIONS

We study the influence of the FLT and in-plane magnetic field on the switching of nanoscale magnetic tunnel junctions with a perpendicular free layer and a W or Ta underlayer. The effective field of the FLT superposes to the component of the in-plane magnetic field transverse to the current. This can be used to reduce or increase the critical switching voltage, the switching reliability, and the activation delay of individual switching events by controlling the magnitude and direction of the external magnetic field. We show that these effects are significant even in materials with a low FLT-to-DLT ratio, such as W. On the contrary, the duration of the reversal phase does not considerably change with the transverse field. Together, these results demonstrate that the FLT directly affects the height of the energy barrier for the nucleation of the reversed domain that initiates the switching. Consequently, the FLT strength can be estimated at the device level from measurements of the switching threshold using a simple macrospin model applied to the activation volume, which accounts for the initial domain nucleation phase before domain expansion takes place. We also perform a systematic micromagnetic study of the critical time and critical current as a function of β , φ , and B_y . The results of the micromagnetic simulations agree with our experimental findings and allow for predicting the switching behavior in material systems with different FLT strengths. Finally, we propose two device designs that allow for selectively addressing MTJs sharing the same current injection track. Selectivity is achieved by varying the alignment of the current, hence of the FLT, relative to the in-plane field, which modifies the critical switching conditions. This approach can be used to create an N-bit memory element with a reduced footprint compared with N separate MTJ devices or a parallel-resistance network with multiple conductance levels allowing for efficient storage and adjustment of synaptic weights.

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